SPECIFICATION

Device Name : Power MOSFET

FMI49N20T2 (T-pack L)

FMC49N20T2 (T-pack S)

Type Name: FMB49N20T2 (T-pack SJ)

 $\mathsf{Spec.\ No.}\qquad :\qquad MS5F6124$

Date : Jun.-17-2005

	DATE	NAME	APPROVED	
DRAWN	Jun17-'05	Y. Hara	401	1
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H04-004-05

Revised Records

Date	Classification	Index	Content	Drawn	Checked	Checked	Approved
Jun17 2005	enactment			Y. Hara	T. HøsEN	T. Kokewa	J.Sdj
Feb22 2006	revise	а	Revised characteristics curve. Added to repetitive avalanche current.	Y. Hara	T. HOSEN	T. Kokuwa	T. plycolo

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1.Scope This specifies Fuji Power MOSFET FMI49N20T2,FMC49N20T2,FMB49N20T2

2.Construction N-Channel enhancement mode power MOSFET

3.Applications for Switching

4.Outview T-pack L Outview See to 8/22 page

T-pack S Outview See to 9/22 page
T-pack SJ Outview See to 10/22 page

5.Absolute Maximum Ratings at Tc=25°C (unless otherwise specified)

Description	Symbol	Characteristics	Unit	Remarks
Drain-Source Voltage	V_{DS}	200	V	
Drain-Source Voltage	V_{DSX}	130	V	VGS=-20V
Continuous Drain Current	I _D	49	А	
Pulsed Drain Current	I _{DP}	± 196	Α	
Gate-Source Voltage	V_{GS}	+30/-20	V	
Non-Repetitive Maximum Avalanche current	I _{AS}	49	А	Note *1
Repetitive Maximum Avalanche current	I _{AR}	25	Α	Note *1
Non-Repetitive Maximum Avalanche Energy	E _{AS}	582.5	mJ	Note *2
Repetitive Maximum Avalanche Energy	E _{AR}	27	mJ	Note *3
Maximum Drain-Source dV/dt	dV _{DS} /dt	20	kV/μs	VDS≤200V
Peak Diode Recovery dV/dt	dV/dt	5	kV/μs	Note *4
Maximum Power Dissipation	P _D	270	W	Tc=25°C
IMAXIIII II OWEI DISSIPATION	ט ' ט	1.67	VV	Ta=25°C
Operating and Storage	T _{ch}	150	°C	
Temperature range	T _{stg}	-55 to +150	°C	

6.Electrical Characteristics at Tc=25°C (unless otherwise specified)

Static Ratings

Description	Symbol	Cond	Conditions		typ.	max.	Unit
Drain-Source		I _D =250μA					
Breakdown Voltage	BV _{DSS}	V _{GS} =0V		200	-	-	V
Gate Threshold		I _D =250μA					
Voltage	$V_{GS}(th)$	$V_{DS} = V_{GS}$		2.0	-	4.0	V
Zero Gate Voltage		V_{DS} =200V V_{GS} =0V	T _{ch} =25°C	-	1	25	μΑ
Drain Current	I _{DSS}	V_{DS} =160V V_{GS} =0V	T _{ch} =125°C	-	1	250	μΑ
Gate-Source		V _{GS} = +30V	/ -20V				
Leakage Current I _{GSS}		V _{DS} =0V		-	-	100	nA
Drain-Source		I _D =24.5A					
On-State Resistance R _{DS} (on)		V _{GS} =10V		-	36.1	47.0	mΩ

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Dynamic Ratings

Description	Symbol	Conditions	min.	typ.	max.	Unit
Forward		I _D =24.5A				
Transconductance	g _{fs}	V _{DS} =25V	13	26	-	S
Input Capacitance	Ciss	V _{DS} =25V	-	6600	9900	
Output Capacitance	Coss	V _{GS} =0V	-	440	660	
Reverse Transfer		f=1MHz		230	345	pF
Capacitance	Crss		-			
	td(on)	V _{cc} =180V	-	34	51	
Turn-On Time	tr	V _{GS} =10V	-	64	96	
	td(off)	I _D =24.5A	-	160	240	ns
Turn-Off Time	tf	R_{GS} =10 Ω	-	94	141	
Total Gate Charge	Q_G	V _{cc} =180V	-	140	210	
Gate-Source Charge Q _{GS}		I _D =49A	-	30	45	nC
Gate-Drain Charge	Q_{GD}	V _{GS} =10V	-	46	69	

Reverse Diode

Description Symbol		Conditions	min.	typ.	max.	Unit
Diode Forward		I _F =49A				
On-Voltage	V_{SD}	V_{GS} =0V T_{ch} =25°C	-	1.00	1.50	V
Reverse Recovery		I _F =49A				
Time	trr	I _F =49A V _{GS} =0V	-	180	1	ns
Reverse Recovery		-di/dt=100A/μs				
Charge	Qrr	T _{ch} =25°C	-	1.25	-	μС

7.Thermal Resistance

Description	Symbol	min.	typ.	max.	Unit
Channel to Case	Rth(ch-c)			0.463	°C/W
Channel to Ambient	Rth(ch-a)			75	°C/W

Note *1 : Tch≤150°C, See Fig.1 and Fig.2

Note *2 : Starting Tch=25°C,I $_{AS}$ =20A,L=2.33mH,Vcc=48V,R $_{G}$ =50 Ω ,See Fig.1 and Fig.2 E $_{AS}$ limited by maximum channel temperature and avalanche current.

See to the 'Avalanche Energy' graph of page 21/22.

Note *3 : Repetitive rating : Pulse width limited by maximum channel temperature.

See to the 'Maximum Transient Thermal impedance' graph of page 22/22.

Note *4 : $I_F \le -I_D$,-di/dt=50A/ μ s,Vcc \le BV $_{DSS}$,Tch \le 150°C

 $\label{prop:condition} \textbf{Fuji}\,\textbf{Electric}\,\textbf{Device}\,\textbf{Technology}\,\textbf{Co.,} \textbf{Ltd.}$

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Fig.1 Test circuit

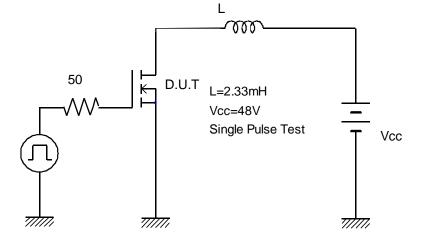
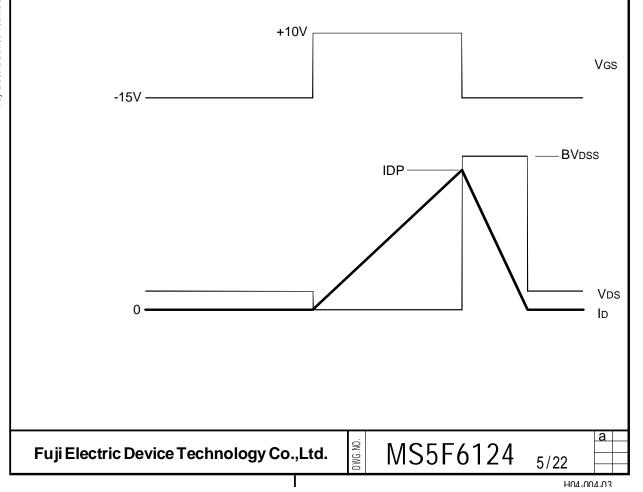


Fig.2 Operating waveforms



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8.Reliability test items

All guaranteed values are under the categories of reliability per non-assembled(only MOSFETs). Each categories under the guaranteed reliability conform to EIAJ ED4701/100 method104 standards.

Test items required without fail.

Humidification treatment (85±2°C,65±5%RH,168±24hr)

Heat treatment of soldering

Through Hole Package (Solder Dipping,260±5°C(265°Cmax.),10±1sec,2 times) SMD Package(IR-ray Reflow ,255±5°C(260°Cmax.),10±1sec,2 times)

	Test	Test	Testing methods and Conditions	Reference	Sampling	Acceptance
	No.	Items		Standard	number	number
	1	Terminal	Pull force			
		Strength	TO-220,TO-220F : 10N	EIAJ		
		(Tensile)	TO-3P,TO-3PF,TO-247 : 25N	ED4701/400	15	
			TO-3PL : 45N	method 401		
		(Through Hole)	T-Pack,K-Pack : 10N			
			Force maintaining duration :30±5sec			
	2	Terminal	Load force			
		Strength	TO-220,TO-220F : 5N	EIAJ		
		(Bending)	TO-3P,TO-3PF,TO-247: 10N	ED4701/400	15	
			TO-3PL : 15N	method 401		
		(Through Hole)	T-Pack,K-Pack : 5N			
8			Number of times :2times(90deg./time)			
٦	3	Mounting	Screwing torque value: (M3)	EIAJ		(0:1)
et		Strength	TO-220,TO-220F: 40±10N cm	ED4701/400	15	
<u>.</u> +			TO-3P,TO-3PF,TO-247 : 50±10N cm	method 402		
tes		(Through Hole)	TO-3PL: 70±10N:cm			
Mechanical test methods	4	Vibration	frequency: 100Hz to 2kHz	EIAJ		
Ξ			Acceleration: 200m/s ²	ED4701/400	15	
) S			Sweeping time : 4min.	method 403		
ĕ			48min. for each X,Y&Z directions.			
	5	Shock	Peak amplitude: 15km/s ²	EIAJ		
			Duration time: 0.5ms	ED4701/400	15	
			3times for each X,Y&Z directions.	method 404		
	6	Solderability	Solder temp. : 245±5°C			
			Immersion time : 5±0.5sec			
			About Through Hole Package type,		15	
			each terminal shall be immersed in			
			the solder bath within 1 to 1.5mm from			
			the body.			
	7	Resistance to	Solder temp. : 260±5°C	EIAJ		
		Soldering Heat	Immersion time : 10±1sec	ED4701/300	15	
		(Through Hole)	Number of times : 1times	method 302		
		Resistance to	Solder temp. : 255±5°C	EIAJ	15	
		Soldering Heat	Immersion time: 10±1sec	ED4701/400		
		(SMD Type)	Number of times : 2times	method 301		
			IR-ray Reflowing			

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	Test	Test	Testing methods and Conditions	Reference	Sampling	Acceptance
	No.	Items		Standard	number	number
	1	High Temp.	Temperature : 150+0/-5°C	EIAJ	22	
		Storage	Test duration: 1000hr	ED4701/200		
				method 201		
	2	Low Temp.	Temperature : -55+5/-0°C	EIAJ	22	
		Storage	Test duration: 1000hr	ED4701/200		
				method 202		1
	3	Temperature	Temperature: 85±2°C	EIAJ		
		Humidity	Relative humidity: 85±5%	ED4701/100	22	
spo		Storage	Test duration: 1000hr	method 103		1
Ę	4	Temperature	Temperature: 85±2°C	EIAJ		
l e		Humidity	Relative humidity: 85±5%	ED4701/100	22	
st		BIAS	Bias Voltage : V _{DS} (max) * 0.8	method 103		
) te			Test duration: 1000hr			
Climatic test methods	5	Unsaturated	Temperature : 130±2°C	EIAJ		(0:1)
<u>=</u>		Pressurized	Relative humidity: 85±5%	ED4701/100	22	
O		Vapor	Vapor pressure : 230kPa	method 103		
			Test duration: 48hr			
	6	Temperature	High temp.side: 150±5°C/30min.	EIAJ		
		Cycle	Low temp.side: -55±5°C/30min.	ED4701/100	22	
			RT:5°C ~ 35°C/5min.	method 105		
			Number of cycles : 100cycles			
	7	Thermal Shock	Fluid : pure water(running water)			
			High temp.side: 100+0/-5°C	EIAJ	22	
			Low temp.side : 0+5/-0°C	ED4701/300		
			Duration time: HT 5min,LT 5min	method 307		
			Number of cycles : 100cycles			
spc	8	Intermittent	∆Tc=90degree	EIAJ		
Ę		Operating	Tch≤Tch(max.)	ED4701/100	22	
me		Life	Test duration : 3000 cycle	method 106		
st	9	HTRB	Temperature : Tch=150+0/-5°C	EIAJ		(2.4)
e e		(Gate-source)	Bias Voltage : +V _{GS} (max)	ED4701/100	22	(0:1)
Endurance test methods			Test duration: 1000hr	method 101		
- La	10	HTRB	Temperature: Tch=150+0/-5°C	EIAJ		
ا کر عالم		(Drain-Source)	Bias Voltage : V _{DS} (max)*1.0	ED4701/100	22	
ш			Test duration: 1000hr	method 101		

Failure Criteria

			Symbols	Failure	Criteria	Unit
		Item		Lower Limit	Upper Limit	
	0	Breakdown Voltage	BVDSS	LSL * 1.0		V
 	aracteristics	Zero gate Voltage Drain-Source Current	IDSS		USL * 2	Α
<u>i</u>	èr:	Gate-Source Leakage Current	IGSS		USL * 2	Α
Electrical	ğ	Gate Threshold Voltage	VGS(th)	LSL * 0.8	USL * 1.2	V
H		Drain-Source on-state Resistance	RDS(on)		USL * 1.2	Ω
	ည	Forward Transconductance	gfs	LSL * 0.8		S
		Diode forward on-Voltage	VSD		USL * 1.2	V
ie.		Marking				
Outvie	≥	Soldering		With eyes or Micr	oscope	
$^{\circ}$		and other damages				

^{*} LSL: Lower Specification Limit

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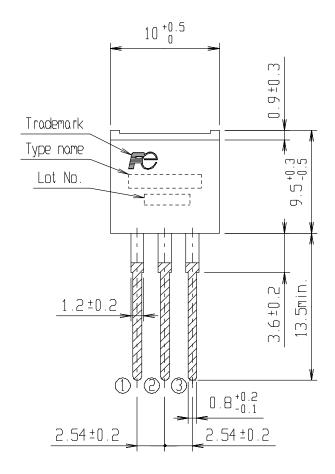
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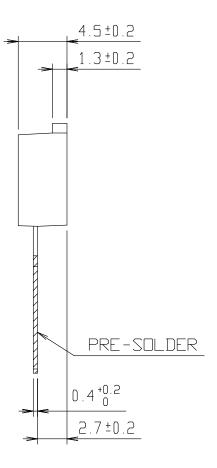
^{*} USL : Upper Specification Limit

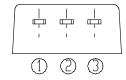
^{*} Before any of electrical characteristics measure, all testing related to the humidity have conducted after drying the package surface for more than an hour at 150°C.

FUJI POWER MOS FET

TYPE : FM [[]]







CONNECTION

- ① GATE
- 2 DRAIN
- 3 SOURCE

DIMENSIONS ARE IN MILLIMETERS.

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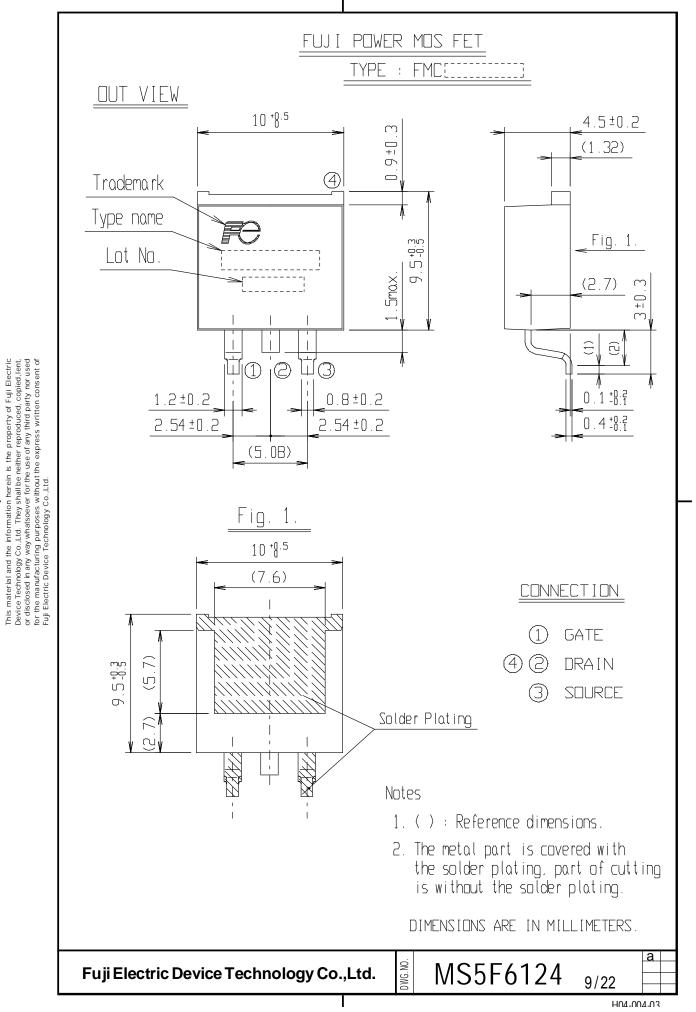
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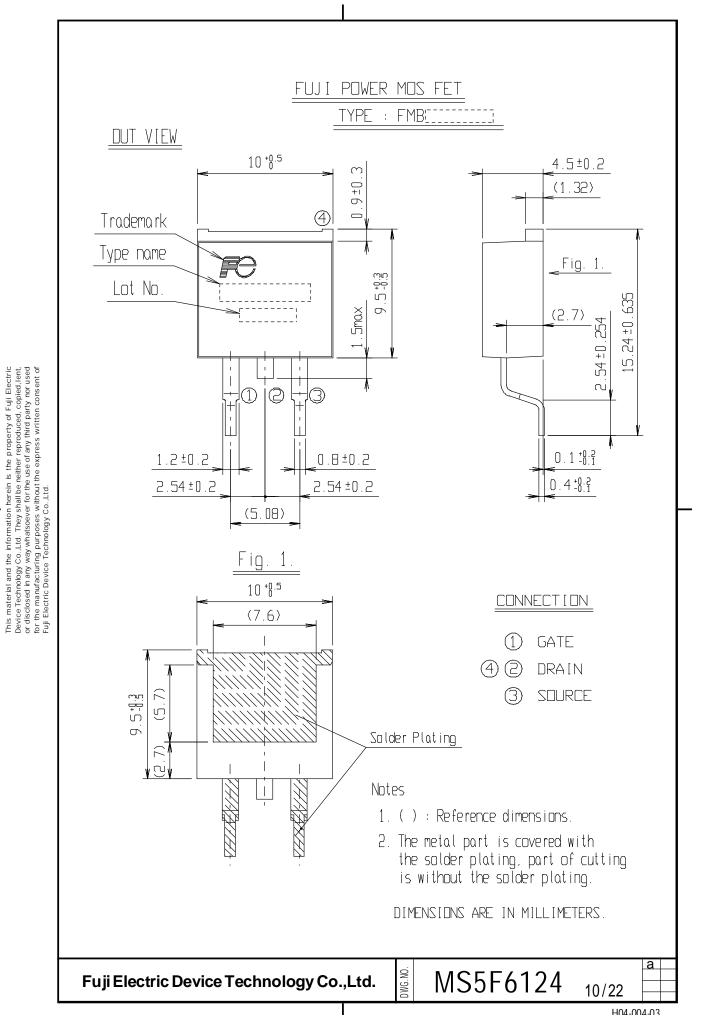
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9. Cautions

- · Although Fuji Electric is continually improving product quality and reliability, a small percentage of semiconductor products may become faulty. When using Fuji Electric semiconductor products in your equipment, you are requested to take adequate safety measures to prevent the equipment from causing physical injury, fire, or other problem in case any of the products fail. It is recommended to make your design fail-safe, flame retardant, and free of malfunction.
- The products described in this Specification are intended for use in the following electronic and electrical equipment which has normal reliability requirements.
- Computers
- OA equipment
- Communications equipment(Terminal devices)

- Machine tools
- AV equipment
- Electrical home appliances etc.

Measurement equipment

- Personal equipment Industrial robots
- The products described in this Specification are not designed or manufactured to be used in equipment or systems used under life-threatening situations. If you are considering using these products in the equipment listed below, first check the system construction and required reliability, and take adequate safety measures such as a backup system to prevent the equipment from malfunctioning.
 - Backbone network equipment
 - Traffic-signal control equipment
 - Submarine repeater equipment
 - · Medical equipment

- Transportation equipment (automobiles, trains, ships, etc.)
- Gas alarms, leakage gas auto breakers
- Burglar alarms, fire alarms, emergency equipment
- · Nuclear control equipment etc.
- Do not use the products in this Specification for equipment requiring strict reliability such as(but not limited
 - Aerospace equipment
- · Aeronautical equipment

10. Warnings

- The MOSFETs should be used in products within their absolute maximum rating(voltage, current, temperature, etc.).
- The MOSFETs may be destroyed if used beyond the rating.
- We only guarantee the non-repetitive and repetitive Avalanche capability and not for the continuous Avalanche capability which can be assumed as abnormal condition .Please note the device may be destructed from the Avalanche over the specified maximum rating.
- The equipment containing MOSFETs should have adequate fuses or circuit breakers to prevent the equipment from causing secondary destruction (ex. fire, explosion etc...).
- Use the MOSFETs within their reliability and lifetime under certain environments or conditions. The MOSFETs may fail before the target lifetime of your products if used under certain reliability conditions.
- Be careful when handling MOSFETs for ESD damage. (It is an important consideration.)
- When handling MOSFETs, hold them by the case (package) and don't touch the leads and terminals.
- It is recommended that any handling of MOSFETs is done on grounded electrically conductive floor and tablemats.

- Before touching a MOSFET terminal, Discharge any static electricity from your body and clothes by grounding out through a high impedance resistor (about $1M\Omega$)
- When soldering, in order to protect the MOSFETs from static electricity, ground the soldering iron or soldering bath through a low impedance resistor.
- You must design the MOSFETs to be operated within the specified maximum ratings(voltage, current, temperature, etc.) to prevent possible failure or destruction of devices.
- Consider the possible temperature rise not only for the channel and case, but also for the outer leads.
- Do not directly touch the leads or package of the MOSFETs while power is supplied or during operation in order to avoid electric shock and burns.
- The MOSFETs are made of incombustible material. However, if a MOSFET fails, it may emit smoke or flame. Also, operating the MOSFETs near any flammable place or material may cause the MOSFETs to emit smoke or flame in case the MOSFETs become even hotter during operation. Design the arrangement to prevent the spread of fire.
- The MOSFETs should not used in an environment in the presence of acid, organic matter, or corrosive gas(hydrogen sulfide, sulfurous acid gas etc.)
- · The MOSFETs should not used in an irradiated environment since they are not radiation-proof.

Installation

 Soldering involves temperatures which exceed the device storage temperature rating. To avoid device damage and to ensure reliability, observe the following guidelines from the quality assurance standard.

Solder temperature and duration (through-hole package)

Solder temperature	Duration
260±5 °C	10±1 seconds
350±10 °C	3.5±0.5 seconds

- The immersion depth of the lead should basically be up to the lead stopper and the distance should be a maximum of 1.5mm from the device.
- · When flow-soldering, be careful to avoid immersing the package in the solder bath.

Recommended soldering condition

		Methods				
Categories	Packages	Wave	Wave	Infrared	Air	Soldering
		Soldering	Soldering	Reflow	Reflow	iron
		(Full dipping)	(Only terminal)			(Re-work)
Through-Hole	TO-3PL	×		×	×	
	TO-3P	×		×	×	
	TO-247	×		×	×	
	TO-3PF	×		×	×	
	TO-220	×		×	×	
	TO-220F	×		×	×	
	T-Pack(L)	×		×	×	
	TO-3PL-7	×		×	×	

: Possible : Limited to 1 time x : Unable

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Refer to the following torque reference when mounting the device on a heat sink. Excess torque
applied to the mounting screw causes damage to the device and weak torque will increase the
thermal resistance, both of which conditions may destroy the device.

Table 1: Recommended tightening torques.

Package style	Screw	Tightening torques	Note
TO-220	M3	30 – 50 Ncm	
TO-220F	IVIS	30 – 30 INCITI	flatness: <=±30μm
TO-3P			roughness : <=10μm
TO-3PF	M3	40 – 60 Ncm	Plane off the edges :
TO-247			C<=1.0mm
TO-3PL	M3	60 –80 Ncm]

- The heat sink should have a flatness within±30µm and roughness within 10µm. Also, keep the tightening torque within the limits of this specification.
- Improper handling may cause isolation breakdown leading to a critical accident.
 ex.) Over plane off the edges of screw hole. (Recommended plane off the edge is C<1.0mm)
- We recommend the use of thermal compound to optimize the efficiency of heat radiation. It is important to evenly apply the compound and to eliminate any air voids.

Installation / SMD Package

 Soldering involves temperatures which exceed the device storage temperature rating. To avoid device damage and to ensure reliability, observe the following guidelines from the quality assurance standard.

Soldering temperature and duration (SMD Package)

	Reflow-Soldering		
Number of times	Twice		
Soldering Temp. & Time	≥230 ,≤50sec		
Package surface Peak Temp. & Time	≤260 ,≤10sec		

Soldering methods (SMD Package)

	Methods						
Packages	Wave Soldering (Full dipping)	Wave Soldering (Only terminal)	Infrared Reflow	Air Reflow	Soldering iron (Re-work)		
T-Pack(S)	×	×			×		
T-Pack(SJ)	×	×			×		
K-Pack(S)	×	×			×		
TFP	×	×			×		

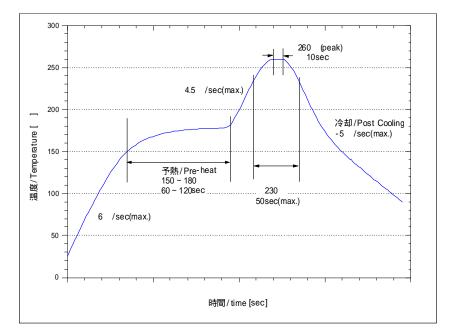
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Recommended Reflow profile



Storage

- The MOSFETs must be stored at a standard temperature of 5 to 35°C and relative humidity of 45 to 75%.
- If the storage area is very dry, a humidifier may be required. In such a case, use only deionized water or boiled water, since the chlorine in tap water may corrode the leads.
- The MOSFETs should not be subjected to rapid changes in temperature to avoid condensation on the surface of the MOSFETs. Therefore store the MOSFETs in a place where the temperature is steady.
- The MOSFETs should not be stored on top of each other, since this may cause excessive external force on the case.
- The MOSFETs should be stored with the lead terminals remaining unprocessed. Rust may cause presoldered connections to fail during later processing.
- The MOSFETs should be stored in antistatic containers or shipping bags.

11.Appendix

- This products does not contain PBBs (Polybrominated Biphenyl) or PBDEs (Polybrominated Diphenyl Ether), substances.
- This products does not contain Class-I ODS and Class-II ODS substances set force by 'Clean Air Act of US' law.
 - If you have any questions about any part of this Specification, please contact Fuji Electric or its sales agent before using the product.
 - Neither Fuji nor its agents shall be held liable for any injury caused by using the products not in accordance with the instructions.
 - The application examples described in this specification are merely typical uses of Fuji Electric products.
 - This specification does not confer any industrial property rights or other rights, nor constitute a license for such rights.

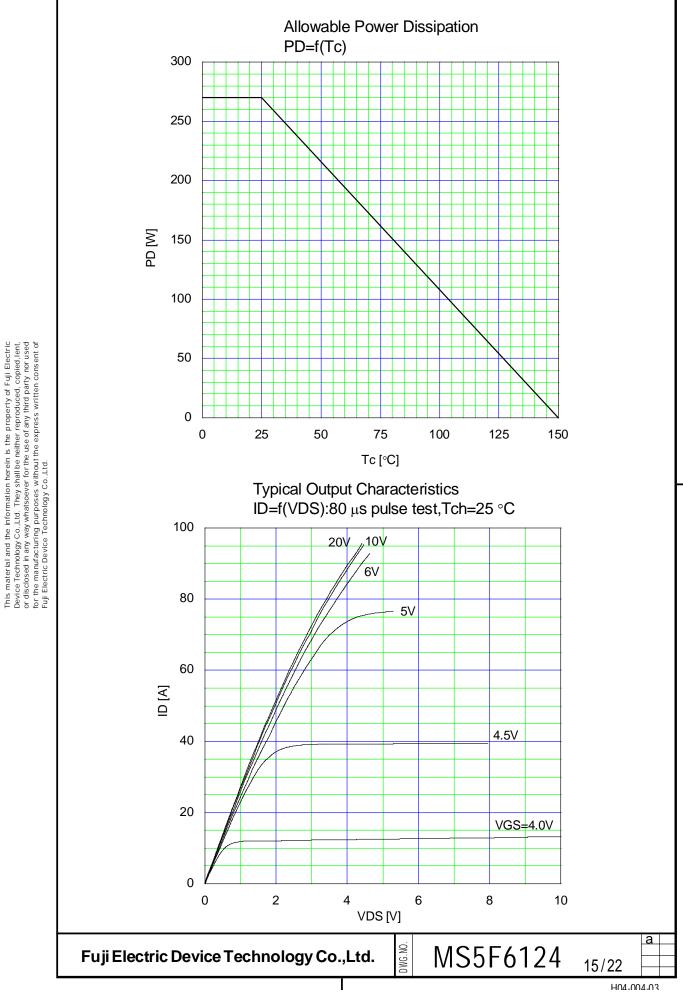
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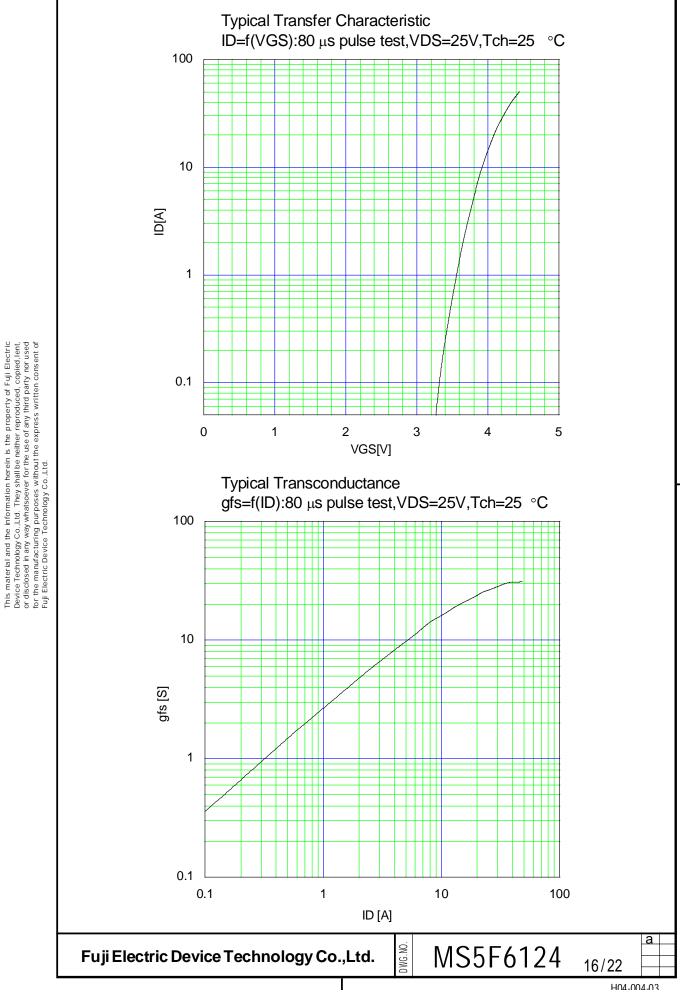
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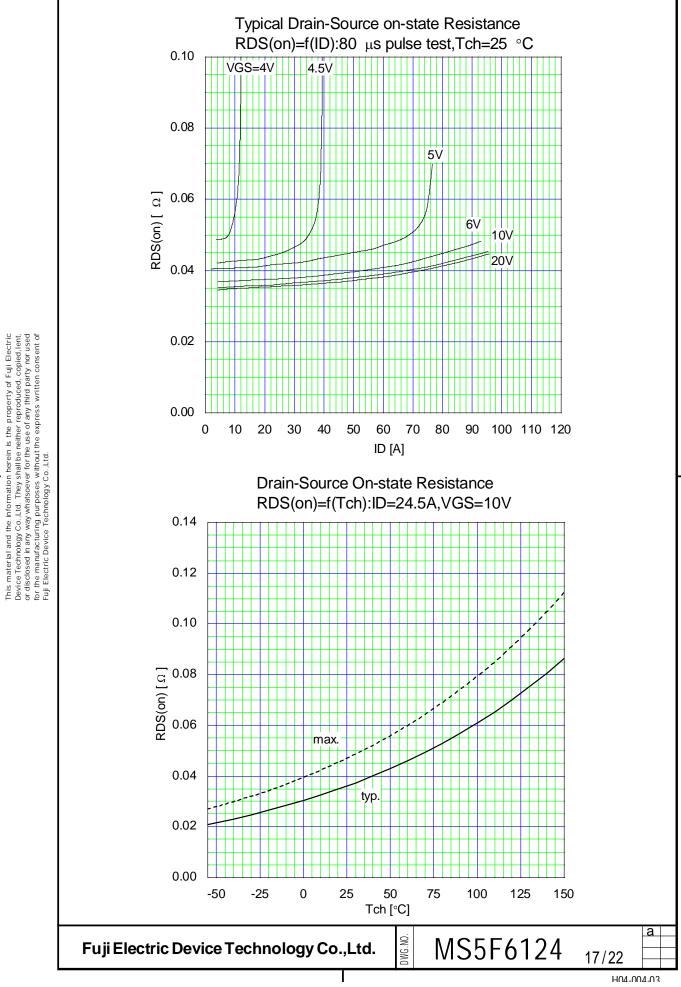
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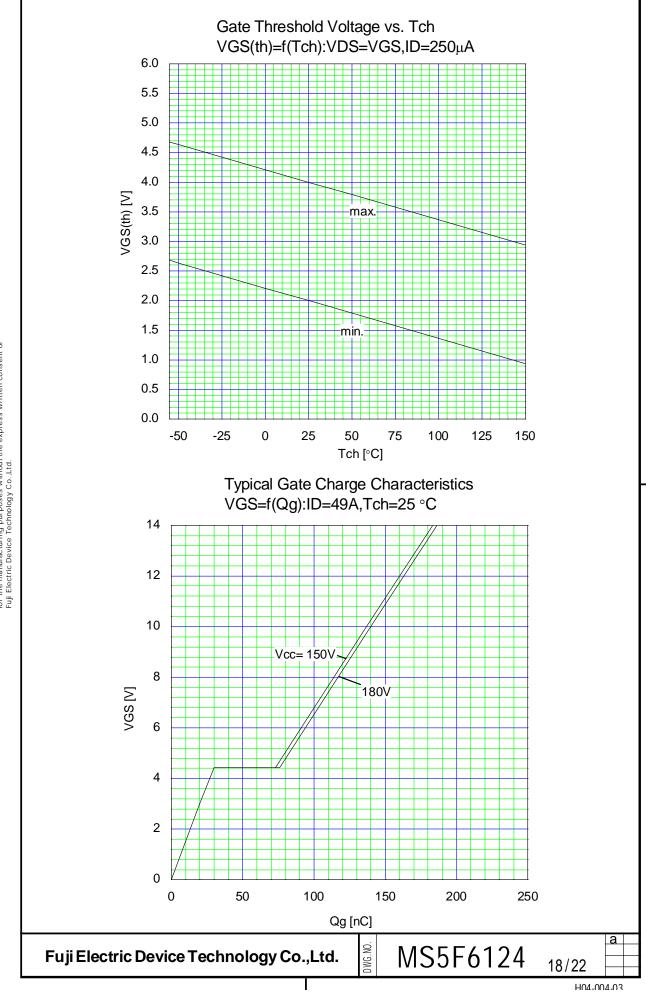
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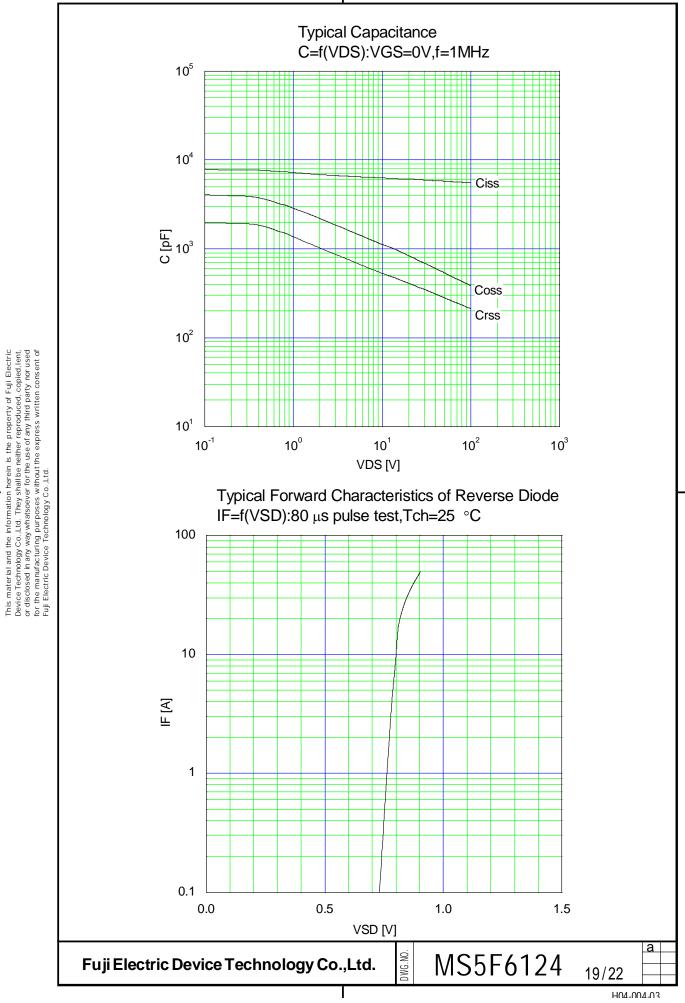
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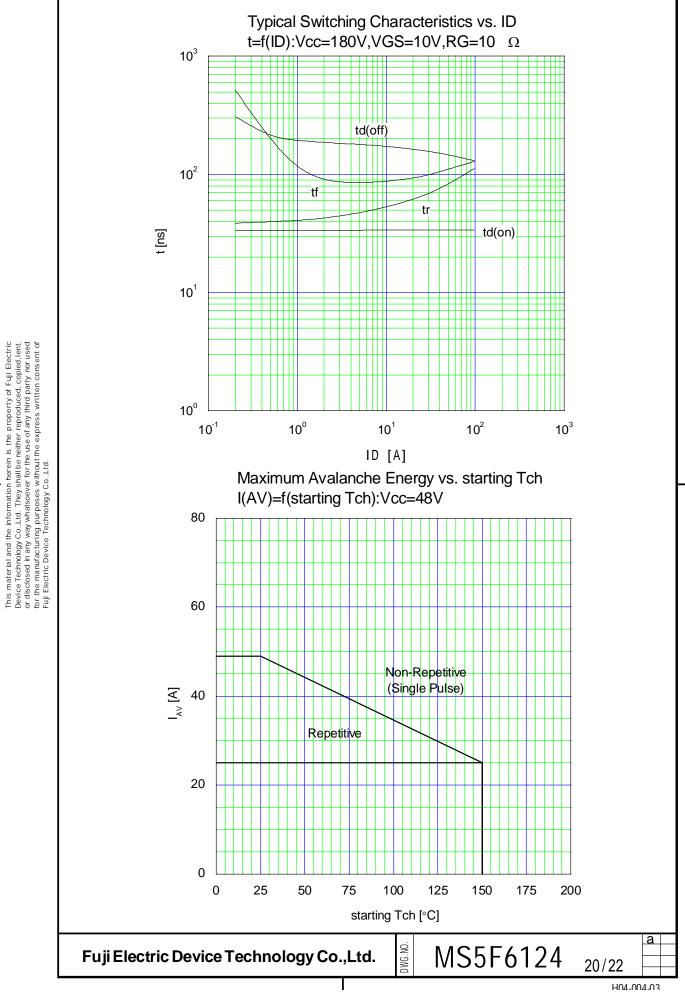


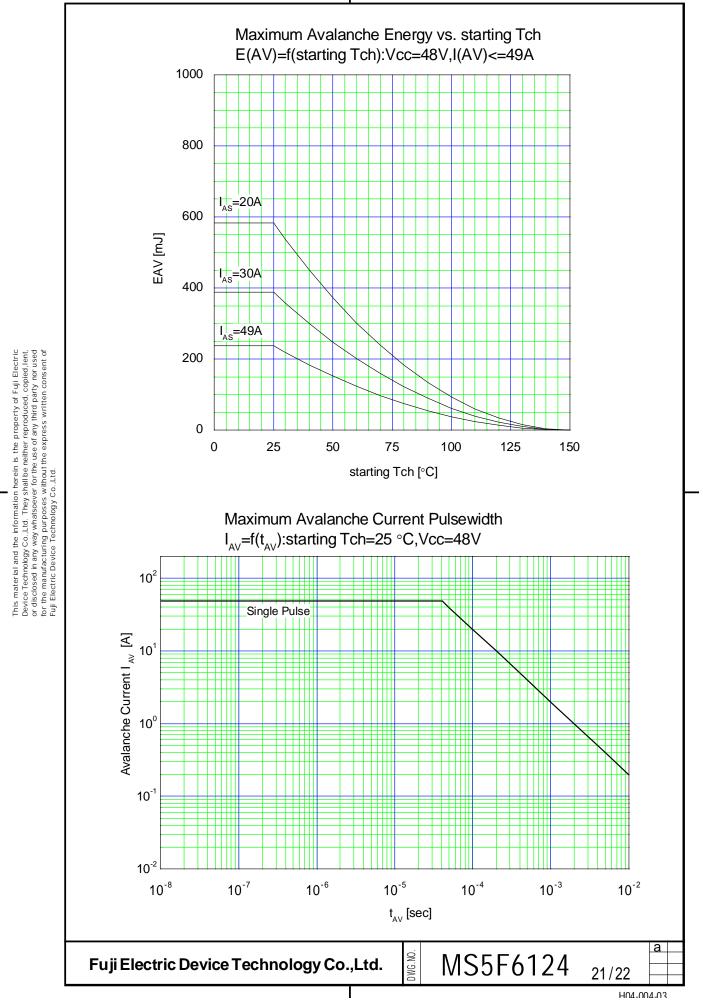


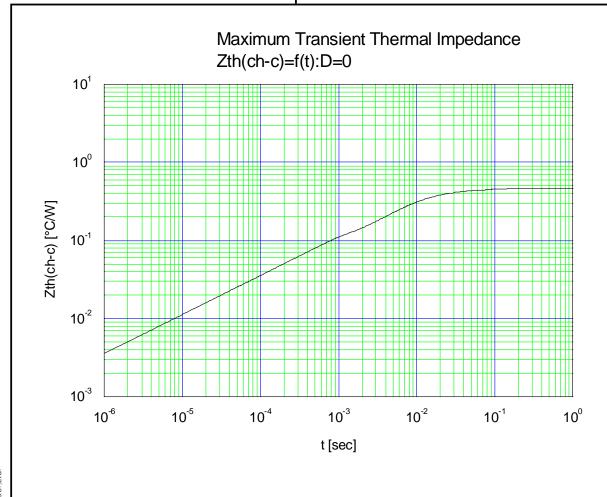












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